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Kyoto University
Direct evidence of the surface track potential

Kaoru Nakajima, Masakazu Sakata, Motofumi Suzuki, and Kenji Kimura*

Department of Micro Engineering, Kyoto University, Yoshida-hommachi, Sakyo, Kyoto 606–8501, Japan

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Angular and energy distributions of fragment protons dissociated from HeH\(^+\) during grazing-angle scattering from a KCl (001) surface are measured. The surface of KCl (001) is heated at 180°C and the beam current is kept lower than 1 fA to prevent macroscopic surface charging. The angular distribution of the fragment protons shows a well-defined peak similarly to the grazing-angle scattering of atomic ions. The observed peak, however, is shifted from the specular angle toward larger scattering angles. The observed angular shift for the trailing proton is larger than that for the leading proton. These results clearly indicate that the motion of the fragment protons is affected by the surface track potential induced by the partner He ion.

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I. INTRODUCTION

When an energetic ion passes through solids, the projectile ionizes the target atoms and a number of vacancies (holes) are created along the ion trajectory. This results in a positive nuclear track potential behind the ion. Although conduction electrons promptly fill the vacancies in conductive materials, the filling process is much slower than the ion-solid interaction time in the case of insulators. Thus, the induced track potential may affect ion-solid interactions, such as secondary electron emission, energy loss, and charge exchange.

The first evidence of the track potential was claimed through the measurement of Auger electrons [1]. Energy shift of carbon KLL Auger electrons up to 68 eV was observed when 100 MeV Ne\(^{9+}\) ions were passing through thin polypropylene foils. The observed energy shift was ascribed to the effect of the nuclear track potential. Similar energy shift was also observed for convoy electrons emitted by 5 MeV/u heavy ions passing through polypropylene foils [2], although the observed energy shift is less than 1% of the convoy electron energy. A more pronounced effect was observed by Gómez et al. using grazing-angle scattering of 60–100 keV H\(^+\) ions at LiF (001) surfaces [3]. They observed that the convoy electrons are decelerated by 5–13 eV, which is as large as 15%–25% of the convoy electron energy, indicating that a strong surface track potential is induced during the grazing-angle scattering of fast ions at insulator surfaces. In a new measurement with a smooth LiF (001) surface, however, they observed acceleration of convoy electrons by 5 eV [4] instead of deceleration. This acceleration was semiquantitatively explained in terms of the surface wake potential (dynamical image potential), suggesting that the effect of the surface track potential is negligibly small. Thus, the existence of the surface track potential is now a subject of controversy.

The difficulty in this kind of measurements is influences of macroscopic charging. It is believed that if the insulators like alkali-metal halides are heated at proper temperatures (>100°C), the macroscopic charging can be avoided by the ionic conduction. This is true when the beam current is far below 1 pA [5]. In order to measure the energy spectrum of the convoy electrons with good statistics, however, a relatively high beam current is required because the production probability of the convoy electron is usually very small. Such a high beam current induces the macroscopic charging even if the insulator surface is heated [5]. Other probing methods compatible with low beam current far below 1 pA are absolutely necessary for studying the surface track potential in detail.

In the present article, the surface track potential is studied using a HeH\(^+\) ion as a probe. The angular and energy distributions of fragment protons dissociated from HeH\(^+\) during grazing-angle scattering at a KCl (001) surface is observed. The motion of the protons should be affected by the surface track potential induced by the partner He ion as well as the proton itself. Because almost all incident ions are reflected from the surface in a narrow range of angles centered at the specular angle, the angular and energy distributions can be measured with good statistics even if the beam current is reduced below 1 fA. Thus, the effect of the surface track potential on the distributions can be observed in detail without suffering from the macroscopic charging.

II. EXPERIMENTAL

A beam of 1 MeV HeH\(^+\) ions was produced by the 4-MV Van de Graaff accelerator of Kyoto University. The beam was collimated by a series of four-jaw slit systems to less than 0.1 × 0.1 mm\(^2\) in size and less than 0.5 mrad in divergence. The collimated beam was incident on the surface of the target crystal at grazing angles. The target crystal was mounted on a five-axis high-precession goniometer in an ultrahigh-vacuum (UHV) scattering chamber (base pressure \(3 \times 10^{-5}\) Pa). The energy spectra of the scattered ions were measured by a 90° sector magnetic spectrometer (energy resolution <0.1%). The spectrometer had a small aperture (diameter 1.5 mm) at the entrance focal point and a one-dimensional position sensitive detector (1D-PSD) at the exit focal plane. The distance between the target and the entrance aperture was 680 mm (the acceptance angle of the entrance aperture is ±1.1 mrad). Two sets of parallel plate electrostatic deflectors were installed between the target and the entrance aperture so that ions scattered at any scattering and azimuth angles
can pass through the aperture by applying appropriate voltages on these deflectors. This allows precise energy measurements of the ions scattered at any direction within ±2° from the incident direction without moving the heavy spectrometer.

Single crystals of KCl (001) and SnTe (001) were used as targets. While both crystals have a NaCl-type structure and the lattice constants are almost the same, the electronic structures are very different; that is, KCl is a typical insulator but SnTe is a narrow gap semiconductor. The effect of the surface track potential was studied with KCl (001) and SnTe (001) was used as a reference material. A single crystal of KCl was cleaved along the (001) plane in air and was mounted on the goniometer. After evacuation and baking the UHV chamber at 150°C for 24 h the KCl (001) was heated at 270°C for 1 h to prepare a clean surface. The surface thus prepared was atomically flat and the mean step density observed by atomic force microscopy was about 5 × 10⁻³ nm⁻¹ [6]. During the measurement, the surface was kept at 180°C to prevent macroscopic surface charging. A single crystal of SnTe (001) was prepared in situ by epitaxial growth on the KCl (001) at 240°C under UHV conditions. High-purity SnTe (99.999%) was evaporated at a low growth rate (less than 0.5 nm/min) for several hours to prepare an atomically flat surface.

III. RESULTS AND DISCUSSION

Figure 1 shows the examples of the observed energy spectra of the fragment protons when 1 MeV HeH⁺ ions were incident on KCl (001) and SnTe (001). Due to the Coulomb explosion, the energy spectra have two peaks. The high energy peak at ~200 keV corresponds to the leading protons and the low energy peak at ~193 keV corresponds to the trailing protons. The observed peak separation is about 6.5 keV for both KCl (001) and SnTe (001). The release energy during the Coulomb explosion is estimated to be ~17 eV, which is in rough agreement with the release energy for the dissociation into He⁺ + H⁺. This indicates that the He⁺ fraction is dominant during the Coulomb explosion.

In the case of SnTe (001), the trailing peak is much larger than the leading peak, similar to the foil transmission experiments [7]. This can be understood by the dynamical image charge (surface wake) induced by the partner He ion. When a positive ion approaches a surface, a negative image charge is induced [see Fig. 2(a)]. If the ion moves parallel to the surface, the induced image charge follows the ion at a distance πν/2ωs (∼0.7 nm in the present case) behind the ion, where ωs is the frequency of the surface plasmon [see Fig. 2(b)]. The dynamical image charge induced by the partner He ion pulls the proton backward during the Coulomb explosion of HeH⁺ and this results in enhancement of the trailing peak [8].

On the other hand, in the case of KCl (001), the surface track potential induced by the partner He ion pushes the proton forward as is schematically shown in Fig. 2(c). Consequently, the yield of the leading proton is expected to be enhanced. The observed result, however, shows that the yield of the leading peak is almost the same as that of the trailing peak. This suggests that neither the surface track potential nor the dynamical image is induced on KCl (001). Even in an insulator surface, however, the dynamical image should be induced, although it is reduced by (ε − 1)/(ε + 1), where ε is dielectric constant of the insulator (ε = 4.85 for KCl). Actually, image acceleration of multiply charged ions was observed at a LiF (001) surface [9]. Thus, the present result strongly suggests the existence of the surface track potential, which accidentally cancels the effect of the dynamical image on the motion of the fragment proton. Although this might be circumstantial evidence of the surface track potential, direct evidence could be provided by measuring the angular distributions of fragment protons.

Figure 3 shows the scattering angle distribution of the fragment protons observed at θ = 0 mrad when 1 MeV HeH⁺ ions are incident on KCl (001) at a grazing angle of incidence, θi, of 4.4 mrad. The distribution has a well-defined peak like the grazing-angle scattering of atomic ions but the peak position (θ = 11 mrad) is shifted from the specular angle (θ = 8.8 mrad) toward larger angle by 2.2 mrad. Such deviation was not observed for SnTe (001). The observed deviation can be explained in terms of the surface track potential. The surface track potential pushes the positive ion outward from the surface [Fig. 2(c)]. In the incoming (outgoing) trajectory, the surface track potential decelerates (accelerates) the perpendicular motion of the projectile ion. For atomic ions the deceleration and the acceleration cancel each other and the ions are scattered at the specular angle. In the case of HeH⁺, the...
dissociation occurs around the apex of the trajectory, that is, during the closest approach to the surface plane. The acceleration of the fragment proton after dissociation is larger than the deceleration of HeH⁺ before the dissociation because the acceleration (deceleration) is inversely proportional to the projectile mass. Consequently, the fragment protons are reflected at scattering angles larger than the specular angle. Thus, the observed shift of the scattering angle seems to be evidence of the surface track potential. The macroscopic charging, however, causes similar angular shift. In order to verify that the observed angular shift is caused by the surface track potential, the induced surface track potential was estimated using a simple model proposed in our previous article [10].

The hole production rate when the fragment He ion travels at $z$ from the surface can be calculated with a binary encounter model,

$$ P_h(z) = \frac{2\pi Z_{\text{eff}}^2 e^4}{m v^2} \sum_i n_i(z) \left( \frac{1}{\varepsilon_i} - \frac{1}{2m v^2} \right), \quad (1) $$

where $Z_{\text{eff}}$ is the effective charge ($Z_{\text{eff}}$ was determined to be 3.3 from the observed charge state distribution of the fragment He ions), $m$ is the electron mass, $n_i(z)$ is the electron density of the $i$th shell averaged over the plane parallel to the surface, and $\varepsilon_i$ is its binding energy. We employed Hartree-Fock wave functions of isolated K and Cl atoms to calculate $n_i(z)$ [11]. When the holes are created they are screened by the ejected electrons. The screening becomes weaker as these electrons move away from the surface. A simple screening function $\Phi(t,z) = 1 - \exp(-V_{\text{SE}}/z)$ was introduced in our previous article, where $V_{\text{SE}}$ is the velocity of the secondary electrons and $t$ is the time after the creation of the hole. Using this simple model with $V_{\text{SE}} = 0.5$ a.u., the observed effect of the surface track potential on the stopping power of atomic projectile ions was successfully reproduced [10]. We use this model to calculate the surface track potential induced by the fragment He ion and the force acting on the partner proton was estimated for various positions of the proton with respect to the He ion. Examples of the perpendicular component, $F_z$, of the calculated force

![Fig. 3. Scattering angle distributions of protons and He ions observed at $\varphi = 0$ mrad when 1 MeV HeH$^+$ ions are incident on KCl(001) at $\theta_i = 4.4$ mrad.](image)

![Fig. 4. Perpendicular component of the force acting on the fragment proton by the surface track potential induced by the partner He ion. Shown are the results for $\Delta x = 0$, ±1, and ±2 a.u. (where positive values correspond to the leading proton). For comparison, the force by the surface continuum potential is shown by a thin solid line. The perpendicular force due to the dynamical image charge induced by the partner He ion for $\Delta x = ±2$ a.u. is also shown by dashed lines.](image)
be explained by the surface track potential but not by the macroscopic charging, confirming that the motion of the fragment proton is affected by the surface track potential induced by the partner He ion.

Finally, we discuss the effect of the dynamical image charge on the scattering angle. The fragment He ion induces dynamical image charge, which may also affect the perpendicular motion of the partner proton. The perpendicular force acting on the trailing and leading protons due to the dynamical image charge can be given by

\[ F_{\text{img}} \approx -\frac{\varepsilon - 1}{\varepsilon + 1} \left( \frac{Z_{\text{eff}} e^2 2z}{(\pi v/2\omega_s \pm \Delta x)^2 + 4z^2} \right)^{3/2}. \]

The calculated \(|F_{\text{img}}|\) with \(\Delta x = 2\) a.u. is shown by dashed lines in Fig. 4, which is much smaller than \(F_z\) around the closest approach to the surface plane. Thus, the effect of the dynamical image charge on the scattering angle should be much smaller than that of the surface track potential.

IV. CONCLUSION

The surface track potential has been studied using HeH\(^{+}\) ions as a probe. The angular and energy distributions of the fragment protons were measured when 1 MeV HeH\(^{+}\) ions were scattered from KCl (001) under grazing incidence. The surface of KCl (001) was heated at 180\(^\circ\)C and the beam current was kept lower than 1 fA to prevent macroscopic surface charging. The observed angular distribution of the fragment protons has a peak at a scattering angle slightly larger than the specular angle. The observed angular shift can be explained by either the surface track potential or the macroscopic charging. By measuring the joint distribution of the fragment protons in the \(E-\theta\) plane, it is found that the angular shift of the trailing protons is larger than that of the leading protons. This clearly indicates that the observed angular shift is caused by the surface track potential.

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